

<b>Notice of References Cited</b>	Application/Control No. 10/015,374	Applicant(s)/Patent Under Reexamination OH ET AL.	
	Examiner Alexander O Williams	Art Unit 2826	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0023994 A1	09-2001	Oka, Takahiro	257/782
	B	US-6,503,776 B2	01-2003	Pai et al.	438/106
	C	US-6,531,784 B1	03-2003	Shim et al.	257/777
	D	US-6,476,475 B1	11-2002	Lee, Melissa Siow-Lui	257/686
	E	US-6,603,072 B1	08-2003	Foster et al.	174/52.4
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.